

M2716/M2716M 16K (2K x 8) UV ERASABLE PROM

Military

- Military Temperature Range M2716M: −55°C to +125°C (T_C) M2716: −55°C to +100°C (T_C)
- 5V ± 10% V_{CC}
- Pin Compatible to Intel's M2732A 32K EPROM
- Fast Access Time: 450 ns Maximum

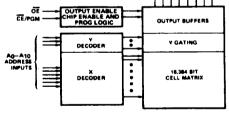
- Static Standby Mode
- Low Power Dissipation of 165 mW Maximum Standby Power
- Inputs and Outputs TTL Compatible During Read and Program
- Not Recommended for New Designs

The Intel M2716M and M2716 are 16,384-bit ultraviolet erasable and electrically programmable read only memories (EPROMs) specified over the military extended temperature range respectively. They operate from a single +5V power supply, have a static power-down mode, and feature fast, single-address location programming. It makes designing with EPROMs faster, easier and more economical. Both products are manufactured from the same dice. Except for the operating temperature range, both products have the same electrical and programming specifictions.

The M2716/M2716M has a static standby mode which reduces the power dissipation without increasing access time. The active power dissipation is reduced by over 60% in the standby power mode. Both are pin compatible to Intel's 32K military EPROM, the M2732A.

The M2716/M2716M has the simplest and fastest method devised yet for programming EPROMs—single pulse TTL level programming. No need for high voltage pulsing because all programming controls are handled by TTL signals. Program any location at any time—either individually, sequentially or at random, with the M2716's single-address location programming. Total programming time for all 16,384 bits is only 100 seconds.

VCC O DATA OUTPUTS OND O OF OUTPUT ENABLE



Block Diagram

271006-3

	Pin Conf	igurations	
M2	716	M27	32A
A, U 2 A, U 3 A, U 4 A, U 5 A, U 6 A, U 7 A, U 8	24 DV cc 23 DA, 22 DA, 21 DV, 20 DOE 19 DA, 18 DOE	A, C 1 A, C 3 A, C 4 A, C 5 A, C 6 A, C 7 A, C 7 A, C 9	24 DV _{cc} 23 DA ₁ 22 DA ₂ 21 DA ₃ 20 DOE V 19 DA ₃ 18 DOE 17 DO, 16 DO.
0,010 0,010 0,011 GNDC 12	16 00, 15 00, 14 00, 13 00,	0,010 0,011 GND 012	15 00, 14 00, 13 00,
	271006-1		271006-2

MO	de	Sei	ect	ЮГ

Pins Mode	CE/PGM (18)	OE (20)	Vpp (21)	V _{CC} (24)	Outputs (9-11, 13-17)	
Read	V _{IL}	VIL	+ 5	+5	D _{OUT}	
Standby	VIH	Don't Care	+5	+5	High Z	
Program	Pulsed VIL to VIH	V _{IH}	+ 25	+5	D _{IN}	
Program Verify	VIL	V _{IL}	+ 25	+5	D _{OUT}	
Program Inhibit	VIL	V _{IH}	+ 25	+5	High Z	

Pin Names

A ₀ -A ₁₀	Addresses
CE/PGM	Chip Enable/Program
ŌĒ	Output Enable
00-07	Outputs

December 1989 Order Number: 271006-003



ABSOLUTE MAXIMUM RATINGS*

 NOTICE: This is a production data sheet. The specifications are subject to change without notice.

*WARNING: Stressing the device beyond the "Absolute Maximum Ratings" may cause permanent damage. These are stress ratings only. Operation beyond the "Operating Conditions" is not recommended and extended exposure beyond the "Operating Conditions" may affect device reliability.

D.C. AND A.C. OPERATING CONDITIONS

	Case Temperature (Instant On)	v _{cc}	V _{PP}
M2716M	-55°C to +125°C	5V ± 10%	Vcc
M2716	-55°C to +100°C	5V ± 10%	Vcc

D.C. CHARACTERISTICS

Symbol	Parameter		Limits			0
Symbol	Parameter	Min	Typ(3)	Max	Units	Comments
ILE	Input Load Current			10	μΑ	$V_{IN} = 5.5V$
l _{LO}	Output Leakage Current			10	μΑ	V _{OUT} = 5.5V
l _{PP1} (2)	V _{PP} Current			6	mA	V _{PP} = 5.5V
I _{CC1} (2)	V _{CC} Current (Standby)		10	30	mA	$\overline{CE} = V_{IH}, \overline{OE} = V_{I}$
I _{CC2} (2)	V _{CC} Current (Active)		57	115	mA	OE = CE = VIL
V _{IL}	Input Low Voltage	-0.1		0.8	V	
V _{IH}	Input High Voltage	2.0		V _{CC} + 1	V.	
VOL	Output Low Voltage			0.45	V	I _{OL} = 2.1 mA
V _{OH}	Output High Voltage	2.4			V	$I_{OH} = -400 \mu A$

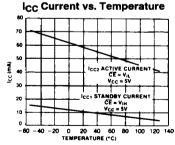
NOTES

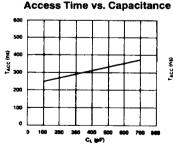
1. V_{CC} must be applied simultaneously or before V_{PP} and removed simultaneously or after V_{PP}.

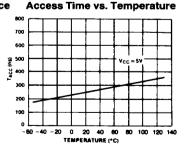
2. Vpp can be connected directly to V_{CC} except during programming. The supply current will then be the sum of I_{CC} and I_{PP1}.

3. Typical values are for T_C = 25°C and nominal supply voltages.

TYPICAL CHARACTERISTICS







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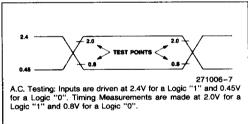
A.C. CHARACTERISTICS

Symbol	Parameter -		Limits			
		Min	Typ(3)	Max	Units	Comments
tACC	Address to Output Delay			450	ns	$\overline{CE} = \overline{OE} = V_{IL}$
t _{CE}	CE to Output Delay			450	ns	OE = V _{IL}
t _{OE}	Output Enable to Output Delay			150	ns	CE = V _{IL}
t _{DF}	Output Enable High to Output Float	0		130	ns	CE = VIL
tон	Output Hold from Addresses, CE or OE Whichever Occurred First	0			ns	$\overline{CE} = \overline{OE} = V_{IL}$

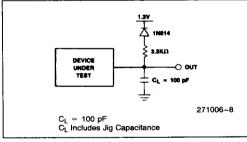
CAPACITANCE T_C = 25°C, f = 1 MHz

Symbol	Parameter	Тур	Max	Units	Conditions
CiN	Input Capacitance	4	6	рF	$V_{IN} = 0V$
Cout	Output Capacitance	8	12	pF	V _{OUT} = 0V

A.C. TESTING, OUTPUT WAVEFORM

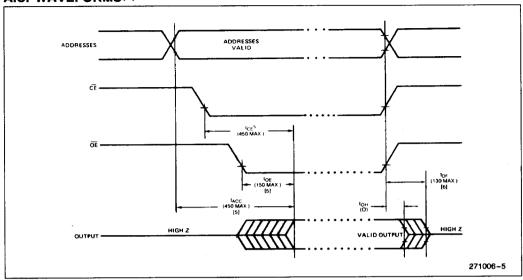


A.C. TESTING LOAD CIRCUIT





A.C. WAVEFORMS(5)



- 1. VCC must be applied simultaneously or before Vpp and removed simultaneously or after Vpp.
- 2. Vpp can be connected directly to VCC except during programming. The supply current will then be the sum of ICC and
- 3. Typical values are for $T_C = 25^{\circ}C$ and nominal supply voltages.
- 4. All times shown in paraentheses are minimum and are nsec unless otherwise specified.
- OE may be delayed up to t_{ACC} t_{OE} after the falling edge of CE without impact on t_{ACC}.
 Output Float is defined as the point where data is no longer driven.

DEVICE OPERATION

The five modes of operation of the M2716 are listed in Table 1. It should be noted that all inputs for the five modes are at TTL levels. The power supplies required are a +5V V_{CC} and a V_{PP}. The V_{PP} power supply must be at 25V during the three programming modes, and must be at 5V in the other two modes.

Read Mode

The M2716 has two control functions, both of which must be logically satisfied in order to obtain data at the outputs. Chip Enable (CE) is the power control and should be used for device selection. Output Enable (OE) is the output control and should be used to gate data to the output pins, independent of de-

Mode Selection

Pins Mode	CE/PGM (18)	ŌE (20)	V _{PP} (21)	V _{CC} (24)	Outputs (9-11, 13-17)
Read	V _{IL}	V _{IL}	+5	+5	D _{OUT}
Standby	V _{IH}	Don't Care	+5	+5	High Z
Program	Pulsed V _{IL} to V _{IH}	V _{IH}	+ 25	+5	D _{IN}
Program Verify	V _{IL}	V _{IL}	+ 25	+5	D _{OUT}
Program Inhibit	VIL	ViH	+ 25	+5	High Z

vice selection. Assuming that addresses are stable, address access time (t_{ACC}) is equal to the delay from \overline{CE} to output (t_{CE}). Data is available at the outputs 150 ns (t_{OE}) after the falling edge of \overline{OE} , assuming that \overline{CE} has been low and addresses have been stable for at least $t_{ACC}-t_{OE}$.

Standby Mode

The M2716 has a standby mode which reduces the active power dissipation by 75%, from 633 mW to 165 mW. The M2716 is placed in the standby mode by applying a TTL high special to the CE input. When in standby mode, the outputs are in a high impedance state, independent of the $\overline{\text{OE}}$ input.

Output Or-Tieing

Because M2716's are usually used in larger memory arrays, Intel has provided a 2 line control function that accommodates this use of multiple memory connections. The two line control function allows for

- a) the lowest possible memory power dissipation, and,
- b) complete assurance that output bus contention will not occur.

To most efficiently use these two control lines, it is recommended that \overline{CE} (pin 18) be decoded and used as the primary device selecting function, while \overline{OE} (pin 20) be made a common connection to all devices in the array and connected to the READ line from the system control bus. This assures that all deselected memory devices are in their low power standby mode and that the output pins are only active when data is desired from a particular memory device.

Programming

Initially, and after each erasure, all bits of the M2716 are in the "1" state. Data is introduced by selectively programming "0's" into the desired bit locations. Although only "0's" will be programmed, both "1's" and "0's" can be presented in the data word. The only way to change a "0" to a "1" is by untraviolet light erasure.

The M2716 is in the programming mode when the V_{PP} power supply is at 25V and \overline{OE} is at V_{IH} . The data to be programmed is applied 8 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL.

When the address and data are stable, a 50 ms, active high, TTL program pulse is applied to the \overline{CE} input. A program pulse must be applied at each address location to be programmed. You can program any location at any time—either individually, sequentially or at random. The program pulse has a maximum width of 55 ms. The M2716 must not be programmed with a DC signal applied to the \overline{CE} input.

Programming of multiple M2716's in parallel with the same data can be easily accomplished due to the simplicity of the programming requirements. Like inputs of the paralleled M2716's may be connected together when they are programmed with the same data. A high level TTL pulse applied to the CE input programs the paralleled M2716's.

Program Inhibit

Programming of multiple M2716's in parallel with different data is also easily accomplished. Except for $\overline{\text{CE}}$, all like units (including $\overline{\text{OE}}$) of the parallel M2716's may be common. A TTL level program pulse applied to a M2716's $\overline{\text{CE}}$ input with V_{PP} at 25V will program that M2716. A low level $\overline{\text{CE}}$ input inhibits the other M2716 from being programmed.

Program Verify

A verify should be performed on the programmed bits to determine that they were correctly programmed. The verify may be performed with V_{PP} at 25V. Except during programming and program verify, V_{PP} must be at 5V.

DEVICE RELIABILITY

The M2716 is built on a proven 2 layer polysilicon NMOS technology. Extensive testing and monitoring has allowed us to achieve failure rates equal to other memory devices.



PROGRAMMING CHARACTERISTICS

D.C. PROGRAMMING CHARACTERISTICS

 $T_C = 25^{\circ}C \pm 5^{\circ}C, V_{CC}^{(1)} = 5V \pm 5\%, V_{PP}^{(1,2)} = 25V \pm 1V$

Symbol	Parameter	Min	Тур	Max	Units	Comments
ILI	Input Current (for Any Input)			10	μΑ	$V_{IN} = 5.25 V \text{ or } 0.45 V$
I _{PP1}	V _{PP} Supply Current			5	mA	CE = V _{IL}
I _{PP2}	V _{PP} Supply Current During Programming Pulse			30	mA	CE = VIH
lcc	V _{CC} Supply Current			100	mA	
V _{IL}	Input Low Level	-0.1		0.8	V	
V _{1H}	Input High Level	2.0		V _{CC} + 1	٧	

A.C. PROGRAMMING CHARACTERISTICS

 $T_C = 25^{\circ}C \pm 5^{\circ}C, V_{CC}^{(1)} = 5V \pm 5\%, V_{PP}^{(1,2)} = 25V \pm 1V$

Symbol	Parameter	Min	Тур	Max	Units	Comments
t _{AS}	Address Setup Time	2			μs	
toes	OE Setup Time	2			μs	
t _{DS}	▼Data Setup Time	2			μs	
t _{AH}	Address Hold Time	2			μs	
^t OEH	OE Hold Time	2			μs	1
t _{DH}	Data Hold Time	2			μs	
t _{DFP}	Output Enable to Output Float Delay	0		200	ns	CE = VIL
^t OE	Output Enable to Output Delay			200	ns	CE = VIL
tpw	Program Pulse Width	45	50	55	ms	
t _{PRT}	Program Pulse Rise Time	5			ns	
tpFT	Program Pulse Fall Time	5			ns	

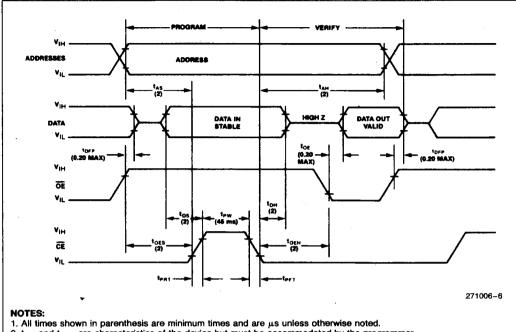
A.C. CONDITIONS OF TEST

Input Rise and Fall Times (10% to 90%)	20 ns
Input Pulse Levels0.8 to	2.2V
Input Timing Reference Level0.8V ar	ıd 2V
Output Timing Reference Level0.8V ar	nd 2V

NOTES:

- 1. V_{CC} must be applied simultaneously or before V_{PP} and removed simultaneously or after V_{PP}. The M2716 must not be inserted into or removed from a board with V_{PP} at 25 ±1V to prevent damage to the device.
- The maximum allowable voltage which may be applied to the Vpp pin during programming is +26V. Care must be taken when switching the Vpp supply to prevent overshoot exceeding this 26V maximum specification.

PROGRAMMING WAVEFORMS



2. toe and toep are characteristics of the device but must be accommodated by the programmer.